Substitute form for form 1449A & 1449B/PTO		Complete if Known
Substitute form for form 14400 of 144001 14	Application No.	09/988,938
INFORMATION DISCLOSURE	Filing Date	February 01, 2002
STATEMENT BY APPLICANT	First Nemed Inventor	Koyacic
SIMIEMENT BY AFFEIGNAT	Group Art Unit	2823
(use as many sheats as necessary)	Examiner Name	Pham, Thanh V.
Sheet 1 of 1	Attorney Docket No.	115-01 US DIV(2)

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		U.S. Patent Document			Date of	Pages, Columns, Lines
Examiner Initials*	Cite,	Number	Kind Code ² (If known)	Name of Patentee or Applicant of Cited Document	Publication of Cited Document MM-DD-YYYY	Where Relevent Passages or Relevent Figures Appear
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		OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS	
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Examinar Date Octored OC 17/04		 			
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¹ Unique citation designation number. 2 See sitisched Kinde of U.S. Patent Documents. 3 Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). 4 For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. 8 Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 18 if possible. 6 Applicant is to place a check mark here if English language Translation is attached.